

Structural Core Self-Test Library for S32K3xx - Contents Product Brief

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1. Software Product Overview

The SCST (Structural Core Self-Test) Library is the software product used for the runtime detection of permanent HW faults in the MCU core. It contains test codes (atomic tests) that stimulates the MCU core submodules with the predefined test vectors and observes and evaluates the core logic response. It typically achieves 90% DC (Diagnostic Coverage). It targets various MCU core submodules, like:

- Data Path units (ALU, Multiplier, Divider),
- Load/Store unit,
- Forwarding logic,
- FPU

The details can be found in the Diagnostic Coverage Estimation document, which is a part of the delivery of each individual SCST product. Faults that are considered as safe (e.g. faults in the debugging logic) are not tested and are excluded from the DC calculation, see Figure 1: NXP's SCST Library content.

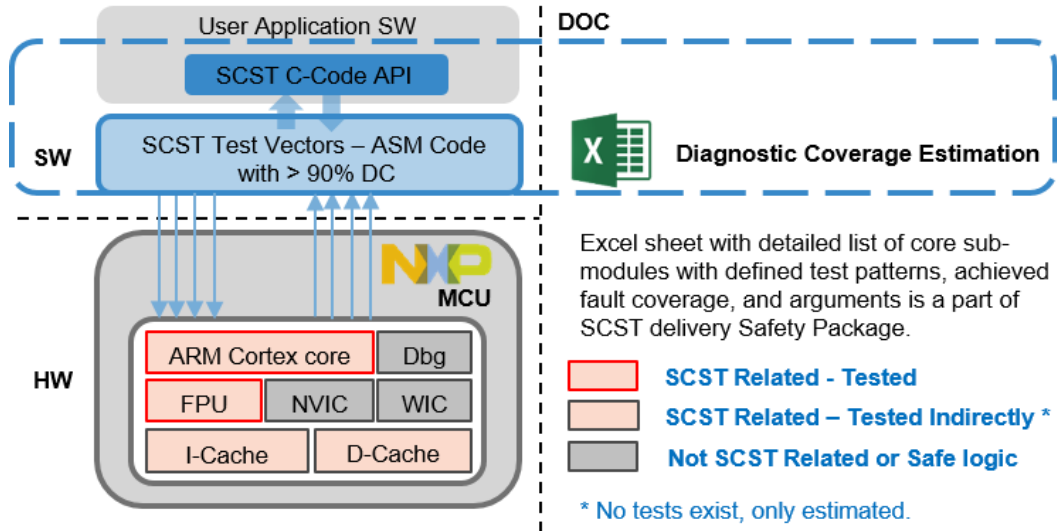


Figure 1. NXP’s SCST Library Content Example

The SCST Library can be used to detect single-point faults or latent faults, see [1] for the fault differentiation. In both cases SCST detect permanent faults only and it is primarily intended for MCU’s which do not use HW techniques supporting safety in terms of permanent fault detection, e.g. delayed-lockstep. If SCST is used to detect latent faults, then it is sufficient to run it only during start-up or shut-down. To detect single-point faults, SCST needs to be executed periodically in runtime. SCST Diagnostic Coverage is estimated analytically. The RTL-code of the core submodules together with Arm® Architecture Manual is examined in detail by the developer. An expert individually analyses the core submodules, defines the test patterns, and analytically estimates DC. SCST is developed as Safety Element out of Context [1]. The highest ASIL assigned to the SCST safety requirements is ASIL-B(D) supporting the achievement of safety goals up to ASIL-D, however in the case when SCST is used to detect single-point faults, SCST diagnostic coverage is sufficient only for ASIL-B. Hence, SCST can be used to support ASIL-B(D) requirements and other run-time measures shall be in place to detect the remaining single-point faults to achieve ASIL-C and ASIL-D metrics.

2. Software Content

The SCST Library is essential in supporting applications to achieve safety. The main components of the SCST Library are as follows:

- SCST Library source code:
 - Is written in Assembly language.
 - Is divided into dedicated atomic tests targeting specific parts of the core.
 - Provides reaction to a detected fault (destroys test signature).
- Simple API written in C:
 - Provides flexible atomic tests execution.
 - Signals first detected fault to the user application.
 - Provides support for atomic test fault injection by destroying test signature to allow to the user application testing it's own fault reaction mechanisms.
 - Conforms with MISRA C standard.
- Fault Coverage Estimation document which:
 - Contains detailed argumentation for the claimed DC estimation.

3. Supported Targets

The SCST Library described in this product brief is available for NXP S32K3xx devices' Arm® Cortex-M7 core.

4. Quality, Standards Compliance and Testing Approach

The M7 SCST Library software product was developed according to the NXP Software Development Processes that is ISO 26262, Automotive-SPICE, IATF16949 and ISO9001 compliant.

5. References

1. ISO 26262-1:2018. Road vehicles - Functional safety - Part 1:Vocabulary, 2018, {ISO 26262-1:2018(E)}.

6. Document Information

Table 1. **Revision History**

Revision number	Date	Substantive changes
1	09/2021	Initial version

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